BU2508AF

GENERAL DESCRIPTION

Enhanced performance, new generation, high-voltage, high-speed switching npn transistor in a plastic full-pack envelope intended for use in horizontal deflection circuits of colour television receivers. Features exceptional tolerance to base drive and collector current load variations resulting in a very low worst case dissipation.

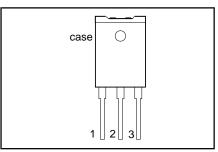
QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
V _{CESM}	Collector-emitter voltage peak value	$V_{BE} = 0 V$	-	1500	V
V_{CEO}	Collector-emitter voltage (open base)		-	700	V
I _C	Collector current (DC)		-	8	Α
1 1	Collector current peak value		-	15	Α
P _{tot}	Total power dissipation	$T_{hs} \leq 25 ^{\circ}C$	-	45	W
V _{CEsat}	Collector-emitter saturation voltage	$T_{hs} \le 25 ^{\circ}C$ $I_{C} = 4.5 A; I_{B} = 1.1 A$	-	1	V
I _{Csat}	Collector saturation current		4.5	-	Α
t _f	Fall time	$I_{Csat} = 4.5 \text{ A}; I_{B(end)} = 1.1 \text{ A}$	0.4	0.6	μs

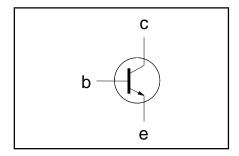
PINNING - SOT199

PIN	DESCRIPTION	
1	base	
2	collector	
3	emitter	
case	isolated	

PIN CONFIGURATION



SYMBOL



LIMITING VALUES

Limiting values in accordance with the Absolute Maximum Rating System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{CESM}	Collector-emitter voltage peak value	$V_{BE} = 0 \text{ V}$	-	1500	V
V _{CEO}	Collector-emitter voltage (open base)		-	700	V
I _C	Collector current (DC)		-	8	Α
I I _{CM}	Collector current peak value		-	15	Α
I _B	Base current (DC)		-	4	Α
I _{BM}	Base current peak value		-	6	Α
-I _{B(AV)}	Reverse base current	average over any 20 ms period	-	100	mΑ
-I _{BM}	Reverse base current peak value 1		-	5	Α
P _{tot}	Total power dissipation	$T_{hs} \leq 25 ^{\circ}C$	-	45	W
T _{stq}	Storage temperature		-65	150	°C
T _j	Junction temperature		-	150	°C

THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
R _{th j-hs}	Junction to heatsink	without heatsink compound	-	3.7	K/W
R _{th j-hs}	Junction to heatsink	with heatsink compound	-	2.8	K/W
R _{th j-a}	Junction to ambient	in free air	35	-	K/W

¹ Turn-off current.

BU2508AF

ISOLATION LIMITING VALUE & CHARACTERISTIC

 T_{hs} = 25 °C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{isol}	Repetitive peak voltage from all three terminals to external heatsink	R.H. ≤ 65 % ; clean and dustfree	ı		2500	V
C _{isol}	Capacitance from T2 to external heatsink	f = 1 MHz	-	22	-	pF

STATIC CHARACTERISTICS

 T_{hs} = 25 $^{\circ}$ C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I _{CES}	Collector cut-off current ²	$V_{BE} = 0 \text{ V}; V_{CE} = V_{CESMmax}$	-	-	1.0	mΑ
I _{CES}		$egin{array}{l} V_{BE} = 0 \ V; \ V_{CE} = V_{CESMmax} \ V_{BE} = 0 \ V; \ V_{CE} = V_{CESMmax}; \ T_i = 125 \ ^{\circ}C \end{array}$	-	-	2.0	mA
I _{EBO}	Emitter cut-off current	$V_{EB} = 7.5 \text{ V}; I_{C} = 0 \text{ A}$	-	-	1.0	mΑ
${\sf BV}_{\sf EBO}$	Emitter-base breakdown voltage	$I_{R} = 1 \text{ mA}$	7.5	13.5	-	V
V _{CEOsust}	Collector-emitter sustaining voltage	I _B = 0 A; I _C = 100 mA; L = 25 mH	700	-	-	V
V_{CEsat}	Collector-emitter saturation voltages	$I_{\rm C} = 4.5 \text{ A}; I_{\rm B} = 1.1 \text{ A}$	-	-	1.0	V
V _{BEsat}	Base-emitter saturation voltage	$I_{\rm C} = 4.5 \text{A}; I_{\rm B} = 1.7 \text{A}$	-	-	1.1	V
h _{FE}	DC current gain	$I_{\rm C} = 100 {\rm mA}, {\rm V}_{\rm CE} = 5 {\rm V}$	-	13	-	
h _{FE}		$I_{C} = 100 \text{ mA}; V_{CE} = 5 \text{ V}$ $I_{C} = 4.5 \text{ A}; V_{CE} = 1 \text{ V}$	4	5.5	7.0	

DYNAMIC CHARACTERISTICS

 T_{hs} = 25 °C unless otherwise specified

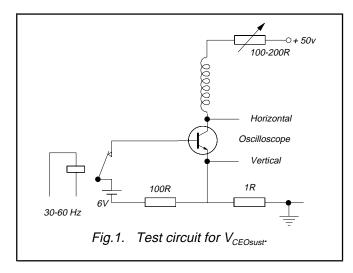
SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
C _c	Collector capacitance	I _E = 0 A; V _{CB} = 10 V; f = 1 MHz	80	-	pF
t _s	Switching times (16 kHz line deflection circuit) Turn-off storage time Turn-off fall time	$\begin{split} I_{Csat} &= 4.5 \text{ A}; \ I_{B(end)} = 1.1 \text{ A}; \ L_{B} = 6 \mu\text{H}; \\ -V_{BB} &= 4 \text{ V}; \ (-dI_{B}/dt = 0.6 \text{ A}/\mu\text{s}) \end{split}$	5.0 0.4	6.0 0.6	μs μs
	Switching times (38 kHz line deflection circuit)	$I_{Csat} = 4.0 \text{ A}; I_{B(end)} = 0.9 \text{ A}; L_{B} = 6 \mu\text{H}; \ -V_{BB} = 4 \text{ V}; (-dI_{B}/dt = 0.6 \text{ A}/\mu\text{s})$			
t _s t _f	Turn-off storage time Turn-off fall time		4.7 0.25	5.7 0.35	μs μs

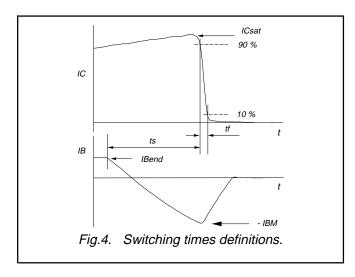
² Measured with half sine-wave voltage (curve tracer).

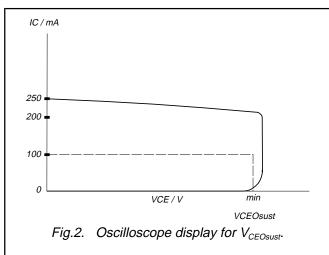
Philips Semiconductors Product specification

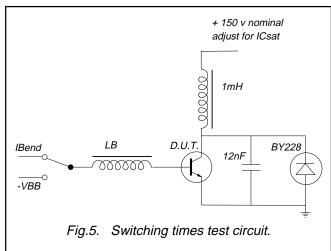
Silicon Diffused Power Transistor

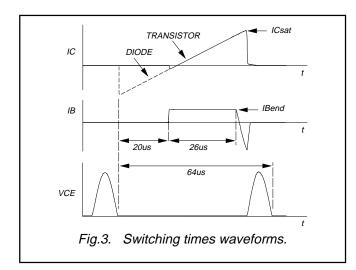
BU2508AF

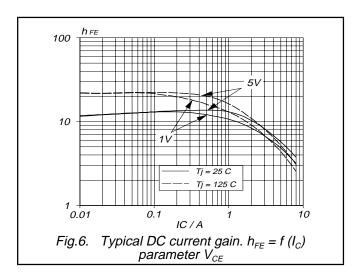








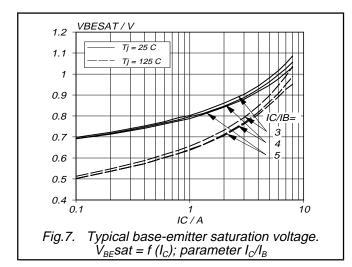


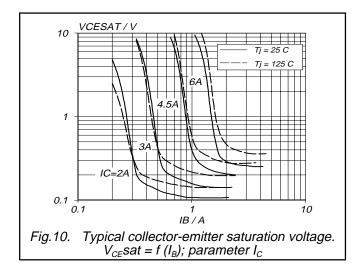


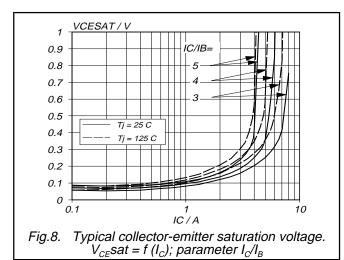
Philips Semiconductors Product specification

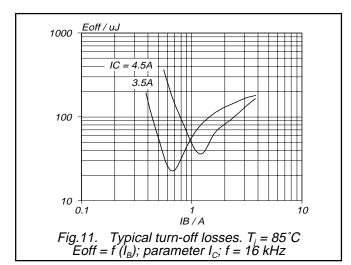
Silicon Diffused Power Transistor

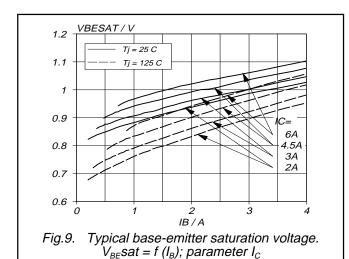
BU2508AF











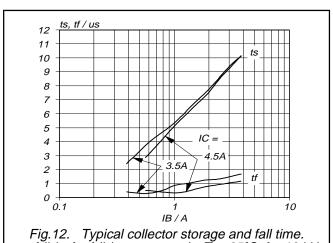


Fig. 12. Typical collector storage and fall time. $ts = f(I_B)$; $tf = f(I_B)$; parameter I_C ; $T_j = 85^{\circ}C$; f = 16 kHz

BU2508AF

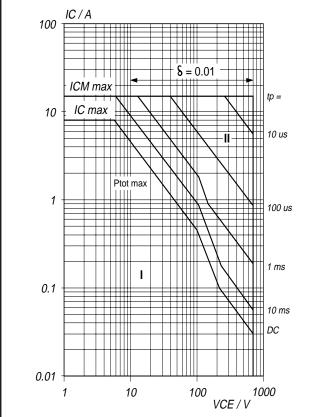


Fig.13. Forward bias safe operating area. $T_{hs} = 25^{\circ}C$ I Region of permissible DC operation. II Extension for repetitive pulse operation.

NB: Mounted with heatsink compound and 30 ± 5 newton force on the centre of the envelope.

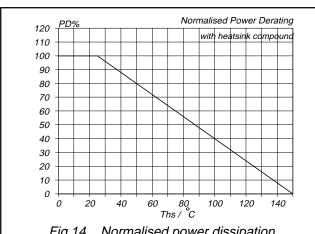


Fig.14. Normalised power dissipation. $PD\% = 100 \cdot P_D/P_{D.25^{\circ}C} = f(T_{hs})$

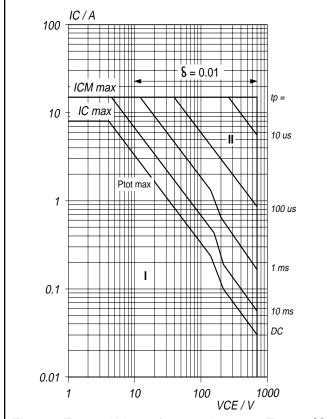
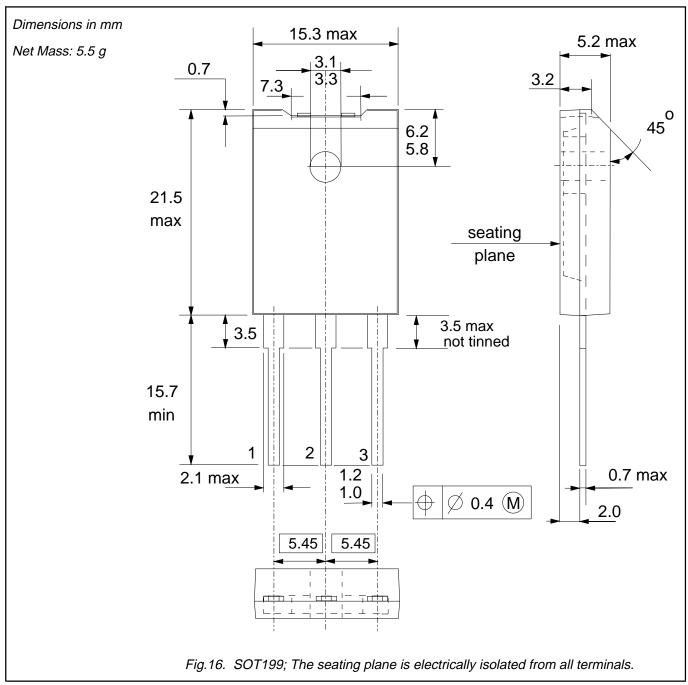


Fig.15. Forward bias safe operating area. $T_{hs} = 25^{\circ}C$ I Region of permissible DC operation. II Extension for repetitive pulse operation.

NB: Mounted without heatsink compound and 30 ± 5 newton force on the centre of the envelope.

BU2508AF

MECHANICAL DATA



- Refer to mounting instructions for F-pack envelopes.
 Epoxy meets UL94 V0 at 1/8".

Philips Semiconductors Product specification

Silicon Diffused Power Transistor

BU2508AF

DEFINITIONS

Data sheet status				
Objective specification	This data sheet contains target or goal specifications for product development.			
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.			
Product specification	This data sheet contains final product specifications.			

Limiting values

Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

© Philips Electronics N.V. 1997

All rights are reserved. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner.

The information presented in this document does not form part of any quotation or contract, it is believed to be accurate and reliable and may be changed without notice. No liability will be accepted by the publisher for any consequence of its use. Publication thereof does not convey nor imply any license under patent or other industrial or intellectual property rights.

LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.

This datasheet has been download from:

www.datasheetcatalog.com

Datasheets for electronics components.